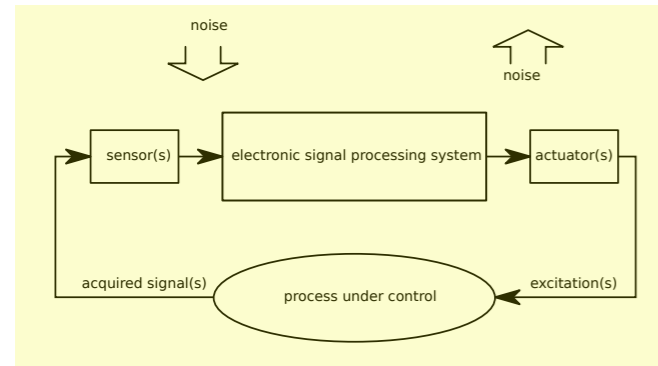


Electromagnetic Compatibility (EMC)

Signal processing in noisy environments



EMC

The ability of an electronic system to operate in its intended electromagnetic environment within a defined safety margin and at a specified performance level.

1. The system does not cause interference with other systems
2. The system is not susceptible to interference from other systems
3. The system does not cause interference with itself

Primary cause of EMC limitation

Finite dimensions of a system that carries electrical signals

Interference mechanisms

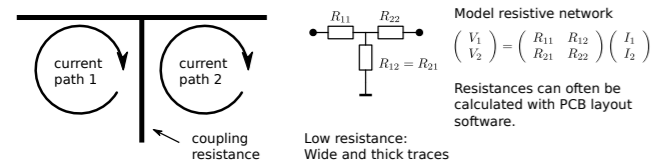
1. Crosstalk (conductive, inductive or capacitive coupling)
2. EM fields (radiative coupling)
3. ESD (electrostatic discharge)

EMC standards

1. Maximum emission levels for radiated and conducted interference
2. Minimum susceptibility levels for radiated and conducted interference
3. Minimum susceptibility levels for ESD

Coupling mechanisms

Conductive coupling



Skin effect

At high frequencies the current migrates towards the surface of the conductor.

$$\delta = \sqrt{\frac{\rho}{\pi f \mu_0}}$$

Proximity effect

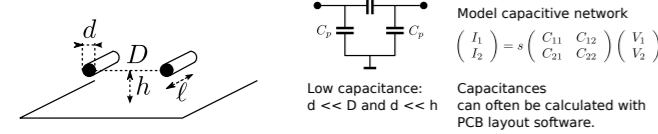
At high frequencies the current migrates towards the surface of the conductor that is facing the return path.

Resistance increases with frequency

Prevent / minimize conductive coupling

Avoid / minimize common return paths for different signals

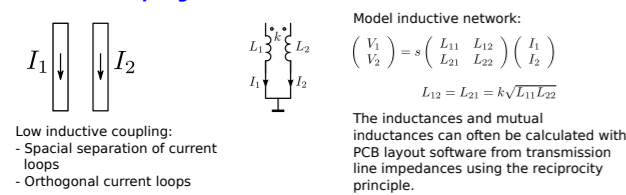
Capacitive coupling



Prevent / minimize capacitive coupling

Maximize distance between different pairs of signal and return path
Apply a shield between different pairs of signal and return path

Inductive coupling



Relation between capacitive and inductive coupling (symmetrical arrangements above)

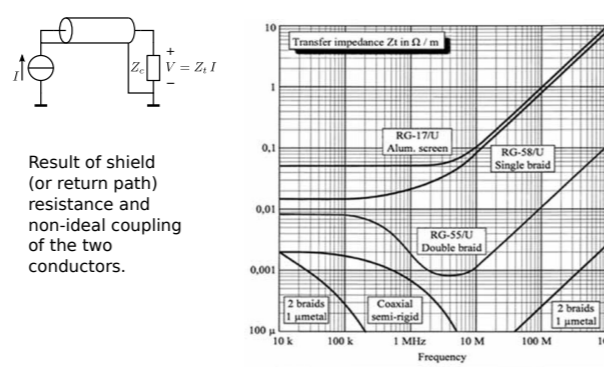
Prevent / minimize inductive coupling

Maximize distance between pairs of signal and return path
Minimize loop area formed by the signal wire/trace/plane and its return path wire/trace/plane
Apply a shield between pairs of signal and return path, this shield should have a large relative permeability, this reduces the skin depth which increases the shielding effect.

Transmission lines

Characteristic impedance: $Z_0 = \sqrt{\frac{L}{C}}$
Lossless propagation delay: $\tau_d = \sqrt{LC}$

Crosstalk via transfer impedance



Prevent / minimize transfer impedance crosstalk

Reduce the noise current by increasing the common-mode impedance
Increase the coupling between the signal and the return path
Use triaxial cable or a differential signal with a shielded twisted pair

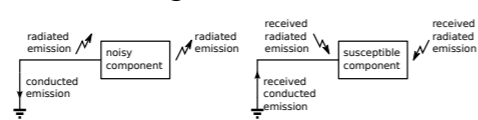
Emission and reception of EM waves

Wave generation

$$\text{rot}(\vec{B}) = \mu_0 \frac{dI}{dt}$$

$$\text{rot}(\vec{E}) = -\frac{\partial \vec{B}}{\partial t}$$

$$\text{rot}(\vec{B}) = -\frac{1}{c^2} \frac{\partial \vec{E}}{\partial t}$$



Prevent / minimize radiated emission and susceptibility for it

Minimize antenna dimensions:
- Loop area signal with its return path
- Length of signal paths

Minimize antenna signals:
- Low voltage and current levels
- Signal bandwidth not larger than necessary

Prevent / minimize conducted emission and susceptibility for it

- Minimize radiated emission
- Increase common-mode impedance of cables

Modeling: lumped versus distributed

Lumped system, near field modeling:
Physical dimensions (very) small with respect to wavelength

Distributed system, far field modeling:
Physical dimensions cannot be ignored with respect to wavelength

EMC measurement tools

Conducted emission

Current clamp measurement

Radiated emission

H-Field loop antenna
Near field measurement with H-field antennas for frequencies below 30 MHz



H-Field sniffer

E-field antennas

Far field measurement with E-field antennas for frequencies above 30 MHz

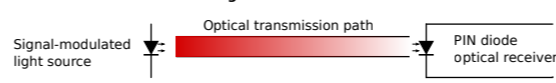
- Many types of e-field antennas
- monopole
 - dipole
 - biconical
 - log-periodic
 - horn

E-Field sniffer



System level design aspects

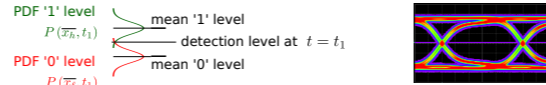
Electrical or non electrical signals



Non-electrical signals are not sensitive for 'electrical noise'

Analog, multi-level digital, or binary signals

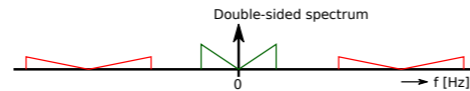
Binary signals have a larger noise immunity than multi-level digital signals
Multi-level digital signals have a larger noise immunity than binary signals



High noise immunity:
- High signal levels
- Maximally limited bandwidth
- Coding: add redundancy + error correction

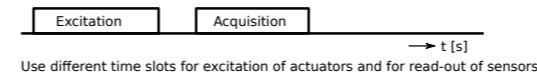
Baseband or bandpass signals (frequency division multiplexing)

Baseband signaling: frequencies of interest centered around zero
Bandpass signaling: frequencies of interest centered around a carrier frequency



- Increase the noise immunity of the signal:
1. Spread the frequency spectrum of the signal
 2. Shift the frequency spectrum of the signal
 3. Reduce out-of-band noise with filtering and frequency-selective detection
 4. Frequency-division multiplexing: use different frequency ranges for different signals

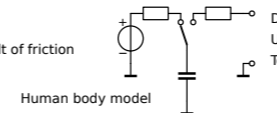
Continuous-time signals or time-division multiplexed signals



Use different time slots for excitation of actuators and for read-out of sensors

ESD

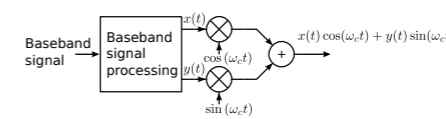
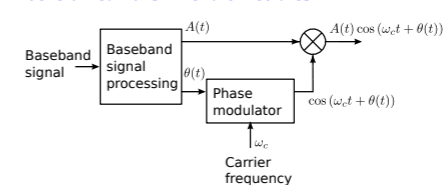
Causes:
- Charge built-up as a result of friction
- Lightning



ESD protection devices

Device	Max. Voltage	Max. Current	Max. Energy	Max. Power
ESD01	200V	100A	20mJ	100W
ESD02	250V	125A	31mJ	125W
ESD03	300V	150A	45mJ	150W
ESD04	350V	175A	61mJ	175W
ESD05	400V	200A	80mJ	200W
ESD06	450V	225A	101mJ	225W
ESD07	500V	250A	125mJ	250W
ESD08	550V	275A	151mJ	275W
ESD09	600V	300A	180mJ	300W
ESD10	650V	325A	211mJ	325W
ESD11	700V	350A	245mJ	350W
ESD12	750V	375A	281mJ	375W
ESD13	800V	400A	320mJ	400W
ESD14	850V	425A	361mJ	425W
ESD15	900V	450A	405mJ	450W
ESD16	950V	475A	451mJ	475W
ESD17	1000V	500A	500mJ	500W

Generalized transmitter architectures



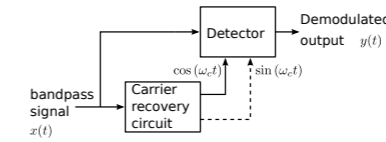
Generalized receiver architecture (quadrature detector)

Nonlinear behavior may result in unintended modulation or demodulation!

AM demodulation in noisy environment
Carrier recovery and synchronous detection

AM demodulation in noisy environment

Carrier recovery and synchronous detection



Carrier recovery methods:
- Bandpass filter cascaded with a limiter
- Narrow-band PLL

Detection methods:
- Analog balanced mixer with low-pass filter(s)
- Digital 4 samples per period and low-pass filter

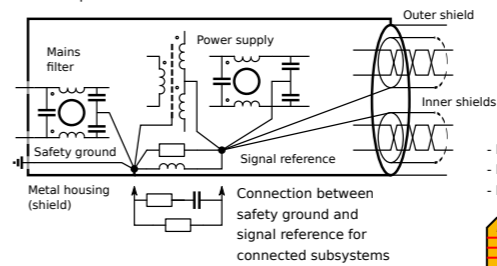
$$y(t) = G \sqrt{x(t) \cos(\omega_c t)^2 + x(t) \sin(\omega_c t)^2}$$

Lock-in amplifier

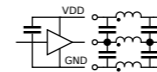


Physical lay-out

Physical layout with safety ground and shielded twisted pair cables

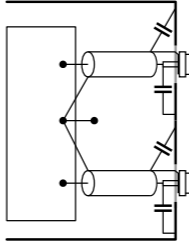


Best connection of a switched output with supply terminals to a multi-pin connector



Equal coupling of output wire to power and ground leads

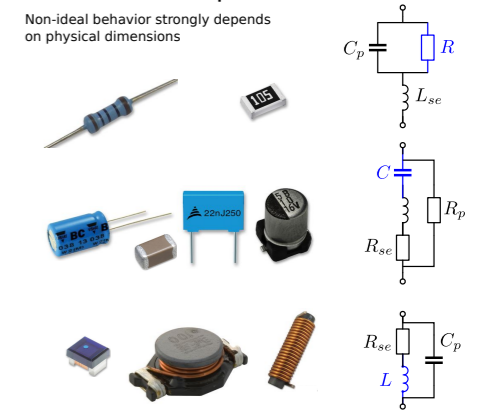
Connection with multiple coaxial cables without safety ground



Circuit level design aspects

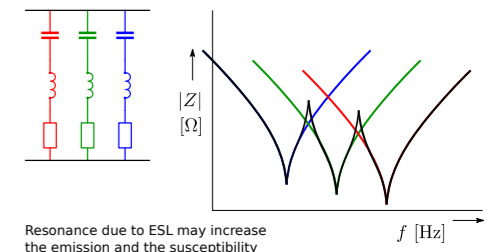
Nonideal behavior of components

Non-ideal behavior strongly depends on physical dimensions

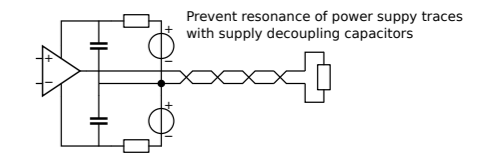


Power supply decoupling

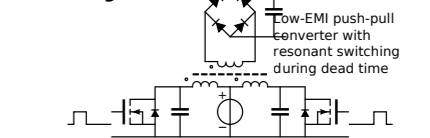
- Reduce radiated emission by power traces and planes
- Reduce susceptibility to radiated emission



Resonance due to ESL may increase the emission and the susceptibility



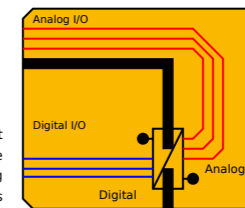
Balancing



PCB lay-out design aspects

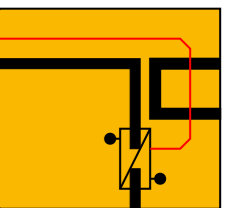
Main rules:

- Minimize noise on power planes
- Maximize coupling between signal and return path (minimize area of high-speed current loops)
- Minimize crosstalk between signals



Example of a correct layout with a single ground plane and separation of analog and digital signals

Example of a wrong layout with a signal trace running over an opening in its return path



Some literature related to EMC design and related topics

